

Search Notes**Application/Control No.**

10/531,468

Applicant(s)/Patent under Reexamination

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Examiner

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Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	8	8/7/2006	KCC
1	9	1	1
706			
710			
712			
438	714		
216	60		
216	61	8/7/2006	KCC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Key words search USPTO, USPTO-pub. EPO, JPO, Derwent, IBM-TDB, inventor search	8/7/2006	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner